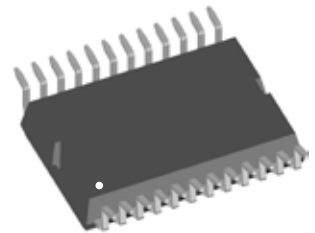
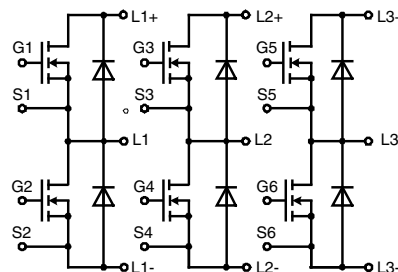


# Three phase full Bridge

with Trench MOSFETs  
in DCB isolated high current package

$V_{DSS} = 100\text{ V}$   
 $I_{D25} = 90\text{ A}$   
 $R_{DSon\ typ.} = 7.5\text{ m}\Omega$



MOSFETs		Maximum Ratings	
Symbol	Conditions		
$V_{DSS}$	$T_{VJ} = 25^{\circ}\text{C to } 150^{\circ}\text{C}$	100	V
$V_{GS}$		$\pm 20$	V
$I_{D25}$	$T_C = 25^{\circ}\text{C}$	90	A
$I_{D90}$	$T_C = 90^{\circ}\text{C}$	68	A
$I_{F25}$	$T_C = 25^{\circ}\text{C (diode)}$	90	A
$I_{F90}$	$T_C = 90^{\circ}\text{C (diode)}$	68	A

### Applications

- AC drives
- in automobiles
    - electric power steering
    - starter generator
  - in industrial vehicles
    - propulsion drives
    - fork lift drives
  - in battery supplied equipment

### Features

- MOSFETs in trench technology:
  - low  $R_{DSon}$
  - optimized intrinsic reverse diode
- package:
  - high level of integration
  - high current capability
  - aux. terminals for MOSFET control
  - terminals for soldering or welding connections
  - isolated DCB ceramic base plate with optimized heat transfer
- Space and weight savings

Symbol	Conditions	Characteristic Values			
		min.	typ.	max.	
$(T_{VJ} = 25^{\circ}\text{C}, \text{ unless otherwise specified})$					
$R_{DSon}^{1)}$	on chip level at } $V_{GS} = 10\text{ V}$	$T_{VJ} = 25^{\circ}\text{C}$	7.5	8.5	$\text{m}\Omega$
		$T_{VJ} = 125^{\circ}\text{C}$	14		$\text{m}\Omega$
$V_{GS(th)}$	$V_{DS} = 20\text{ V}; I_D = 1\text{ mA}$		2.5	4.5	V
$I_{DSS}$	$V_{DS} = V_{DSS}; V_{GS} = 0\text{ V}$	$T_{VJ} = 25^{\circ}\text{C}$		1	$\mu\text{A}$
		$T_{VJ} = 125^{\circ}\text{C}$	0.1		$\text{mA}$
$I_{GSS}$	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0\text{ V}$			0.2	$\mu\text{A}$
$Q_g$	} $V_{GS} = 10\text{ V}; V_{DS} = 65\text{ V}; I_D = 90\text{ A}$		90		nC
$Q_{gs}$			30		nC
$Q_{gd}$			30		nC
$t_{d(on)}$	} inductive load $V_{GS} = 10\text{ V}; V_{DS} = 48\text{ V}$ $I_D = 70\text{ A}; R_G = 33\ \Omega;$ $T_J = 125^{\circ}\text{C}$		130		ns
$t_r$			95		ns
$t_{d(off)}$			290		ns
$t_f$			55		ns
$E_{on}$			0.4		mJ
$E_{off}$		0.4		mJ	
$E_{recoff}$		0.007		mJ	
$R_{thJC}$				1.0	K/W
$R_{thJH}$	with heat transfer paste (IXYS test setup)		1.3	1.6	K/W

<sup>1)</sup>  $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin\ to\ chip})$

### Source-Drain Diode

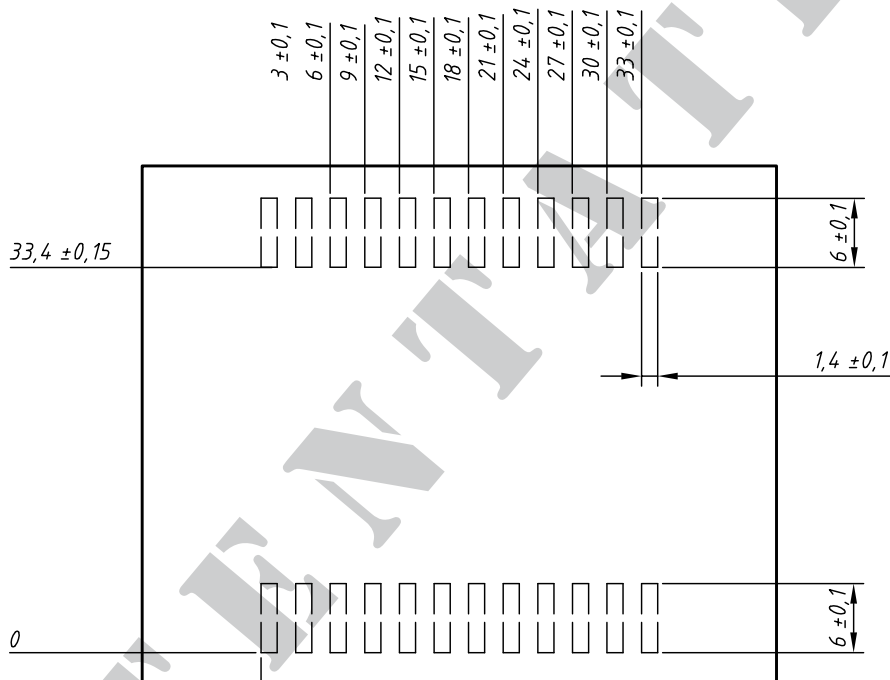
Symbol	Conditions	Characteristic Values			
		min.	typ.	max.	
$V_{SD}$	(diode) $I_F = 70\text{ A}; V_{GS} = 0\text{ V}$		0.9	1.2	V
$t_{rr}$	$I_F = 70\text{ A}; -di_F/dt = 800\text{ A}/\mu\text{s}; V_R = 48\text{ V}$		55		ns
$Q_{RM}$			0.95		$\mu\text{C}$
$I_{RM}$			33		A

### Component

Symbol	Conditions	Maximum Ratings	
$I_{RMS}$	per pin in main current paths (P+, N-, L1, L2, L3) may be additionally limited by external connections 2 pins for output L1, L2, L3	75	A
$T_J$		-55...+175	$^{\circ}\text{C}$
$T_{stg}$		-55...+125	$^{\circ}\text{C}$
$V_{ISOL}$	$I_{ISOL} \leq 1\text{ mA}, 50/60\text{ Hz}, f = 1\text{ minute}$	1000	V~
$F_C$	mounting force with clip	50 - 250	N

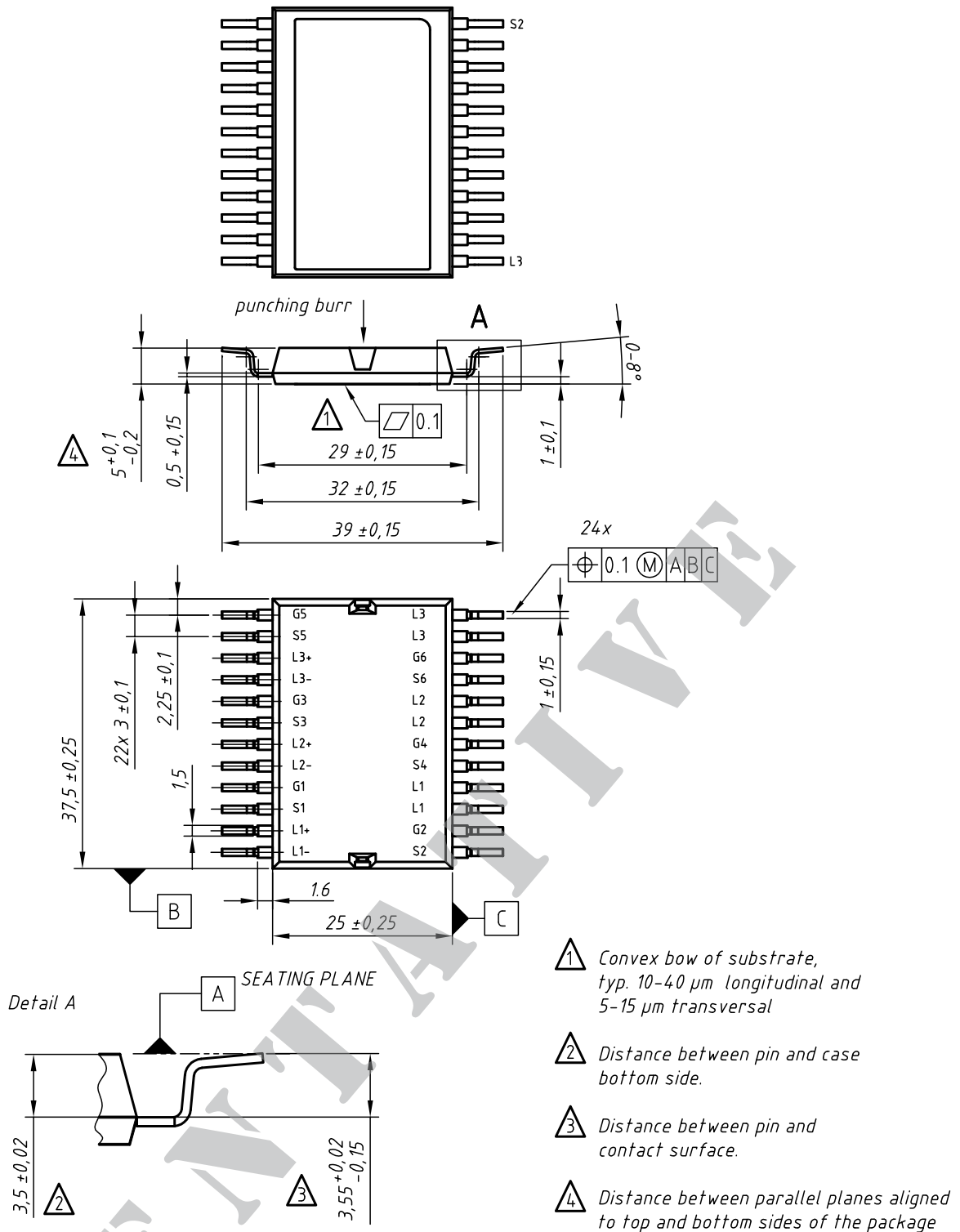
Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$R_{pin\ to\ chip}^{1)}$			tbd	$\text{m}\Omega$
$C_P$	coupling capacity between shorted pins and back side metallization		160	pF
<b>Weight</b>			25	g

<sup>1)</sup>  $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin\ to\ Chip})$



Remarks:

- 1) pin layout / dimensions are conditionally
- 2) soldering paste thickness: 200 $\mu\text{m}$



contact pin:

- galv. tin plating, per pin side: Sn 10...25  $\mu$ m, undercoating Ni 0,2...1  $\mu$ m
- stamping edges may be free of tin
- punching burr:  $\leq 0,05$ mm

Leads	Ordering	Part Name & Packing Unit Marking	Part Marking	Delivering Mode	Base Qty.	Ordering Code
SMD	Standard	GMM 3x100-01X1 - SMD	GMM 3x100-01X1	Blister	28	509 035